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Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)

2) Limit your search by using search operators and field codes, if desired.

Example: optical <and> (fiber <or> fibre) <in> ti

3) Limit the results by selecting Search Options.

4) Click Search. See [Search Examples](#)

```
(watermark* <or>
steganograph* <or> embedding
<or> hiding) <and> (indexed
<near/1> image)
```

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- 4) Click Search. See [Search Examples](#)

```
(watermark* <or>
steganograph* <or> embedding
<or> hiding) <and> (indexed
representation)
```

Start Search

Clear

Note: This function returns plural and suffixed forms of the keyword(s).

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```
(watermark* <or>
steganograph* <or> embedding
<or> hiding) <and> parity
```

Start Search

Clear

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Computer, Volume: 23, Issue: 7, July 1990

Pages:84 - 88

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- 4) Click Search. See [Search Examples](#)

```
(watermark* <or>
steganograph* <or> embedding
<or> hiding) <and> (colourmap
<or> colormap)
```

Start Search

Clear

Note: This function returns plural and suffixed forms of the keyword(s).

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```
(watermark* <or>
steganograph* <or> embedding
<or> hiding) <and> ((color
<or> colour) <near/2> map)
```

Start Search

Clear

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row <and> column <and> parit*
<and> (image <or> photo <or>
photograph)

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